Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/707,151	LANE ET AL.	
Examiner	Art Unit	
Henry K. Choe	2817	

	SEARCHED						
Class	Subclass	Date	Examiner				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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NPL (IEEE)		"	